

INFORMATION DISCLOSURE STATEMENT

SHEET 1 OF 1

Complete if known

Application Number: 10/071,261

Filing Date: February 7, 2002

First Named Inventor: Steinberg, et al.

Group Art Unit: 2874

Examiner Name: Healy, Brian

Attorney Docket Number: ACT - 181

UNITED STATES PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	PATENT NUMBER	ISSUE DATE MM-DD-YYYY	FIRST NAMED INVENTOR
B.M.H.		5479426	12/26/1995	Nakanishi, et al.
B.M.H.		6132107	10/17/2000	Morikawa
B.M.H.		6257772	07/10/2001	Nakanishi, et al.

FOREIGN PATENT DOCUMENTS

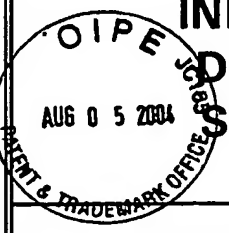
EXAMINER'S INITIALS	CITE NO.	DOCUMENT NUMBER	COUNTRY OR REGION	DATE OF PUBLICATION MM-DD-YYYY	FIRST NAMED INVENTOR OR APPLICANT

OTHER PRIOR ART - NON-PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in Capital Letters), title of the article (when appropriate), title of the item(book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published

EXAMINER'S SIGNATURE	B. Healy	DATE CONSIDERED	11/18/04
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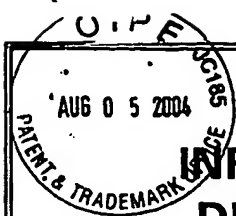
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP §609. Draw a line through citation if citation not in conformance and reference not considered. Include a copy of this form with next communication to applicant.

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UNITED STATES PATENT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.	PATENT NUMBER	ISSUE DATE MM-DD-YYYY	FIRST NAMED INVENTOR
BWV		4021097	05/03/1977	McMahon
BWV		4181400	01/01/1980	Malsot, et al.
BWV		4225213	09/30/1980	McBride, Jr., et al.
BWV		4253735	03/03/1981	Kawamura, et al.
BWV		4362367	12/07/1982	Hammer, et al.
BWV		4411057	10/25/1983	Duda, et al.
BWV		4601541	07/22/1986	Shaw, et al.
BWV		4683560	7/28/1987	Takeuchi, et al.
BWV		4706061	11/10/1987	Johnson
BWV		4784721	11/15/1988	Holmen; et al.
BWV		4812002	03/14/1989	Kato, et al.
BWV		4837129	06/06/1989	Frisch, et al.
BWV		4830450	05/16/1989	Connell, et al.
BWV		4904036	02/27/1990	Blonder
BWV		4938841	07/03/1990	Shahar, et al.
BWV		4945400	07/31/1990	Blonder, et al.
BWV		4957592	09/18/1990	O'Neill
BWV		5024500	06/18/1991	Stanley, et al.
BWV		5095386	03/10/1992	Scheibengraber
BWV		5135590	08/04/1992	Basavanhally, et al.
BWV		5281301	01/25/1994	Basavanhally
BWV		5339377	08/16/1994	Takahashi

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Group Art Unit: 2874-2883

Examiner Name: Healy, Brian

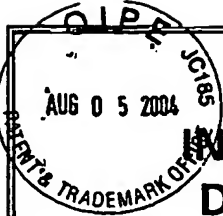
SHEET 2 OF 3

Attorney Docket Number: ACT - 181

BWA		5357593	10/18/1994	Bossler
BWA		5381231	01/10/1995	Tu
BWA		5384872	01/24/1995	Jacobs-Cook, et al.
BWA		5440657	08/08/1995	Essert
BWA		5507911	04/16/1996	Greiff
BWA		5760305	06/02/1998	Greiff
BWA		5781675	07/14/1998	Tseng, et al.
BWA		5844723	12/01/1998	Snyder
BWA		5852308	12/22/1998	Wood
BWA		5886249	03/23/1999	Bonne, et al.
BWA		5896481	04/20/1999	Beranek, et al.
BWA		5966493	10/12/1999	Wagoner, et al.
BWA		6023546	02/08/2000	Tachigori
BWA		6088168	06/11/2000	Snyder
BWA		6146917	11/14/2000	Zhang, et al.
BWA		6212320	04/03/2001	Rickman, et al.
BWA		6428053	08/06/2002	Tai, et al.
BWA		6511235	01/28/2003	Wu, et al.
BWA		6548371	04/15/2003	Fujimaki
BWA		6553173	04/22/2003	Goto
BWA		2003/0059622	03/27/2003	Steinberg, et al.
BWA		2003/0034438	02/20/2003	Sherrer, et al.
BWA		2002/0195417	12/26/2002	Steinberg
BWA		2003/0021572	01/30/2003	Steinberg
BWA		2003/0067049	04/10/2003	Steinberg, et al.

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<i>B. Healy</i>		03/008139	WO	01/30/2003	Steinberg

OTHER PRIOR ART - NON-PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in Capital Letters), title of the article (when appropriate), title of the item(book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published
<i>B. Healy</i>		BRUGGER, J., et al., "Self-aligned 3D shadow mask technique for patterning deeply recessed surfaces of micro-electro-mechanical systems devices", Sensors and Actuators 76, pp. 329-334. 1999.
<i>B. Healy</i>		FLEMING, J.G., "Combining the best of bulk and surface micromachining using Si{111} substrates", SPIE Vol. 3511, pp. 162-168. September 1998.
		MADOU, Marc, "Fundamentals of Fabrication", CRC Press, pp. 174-178, 1997.

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